Microwave studies of Wigner solid phases in bilayer systems

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High B Termination of FQH series: insulator and resonance

3:



- experiment: insulation + resonance $n \sim 1/5$
- Resonance: signature of pinned Wigner crystal
- resonance understood as pinning mode, in which solid oscillates within disorder potential

Resonance: pinning mode interpretation

Disorder induces "Pinning" Mode: small oscillation about pinned positions



Wigner solids in QHE systems

Predicted low-v state: Lam and Girvin; Levesque, Weis, MacDonald `84, Lozovik and Yudson `75, Yang and Rezayi, '02

- `84,
- Spatial charge distribution effect on NMR lineshape: L. Tiemann, T. D. Rhone, N. Shibata, and K. Muraki, Nat. Phys. '14.
- Tunneling approach (Ashoori, arxiv)
- Composite Fermion Wigner crystal Archer, Park, Jain, PRL '13; Rhim, Jain, Park, PRB '15

Resonance: pinning mode of electron solid, v ranges of resonances



Resonance depends on disorder and solid stiffness: **phase transitions, to/ between solids** at v, T where dc just shows QHE or IP



Microwave measurement, coupling to 2DES



- f-independent extinction $P = \exp(-Z_0 \operatorname{Re}(\sigma_{xx})N_{sq})$
- Z_0 characteristic impedance for $\sigma_{xx}=0$, $N_{sq}=2I/W$, I is line length
- Formula is for high *f*, low loss limit.



- Double quantum well CF liquid+ WS
- Multiple Wigner solid phases in bilayer-regime wide QW

Wigner Solid + Composite Fermion Liquid



Double quantum well: 10 nm barrier, 30 nm wells

Highly unbalanced layer densities: $n_H \sim 1.5 \times 10^{11}$, $n_L \sim 2 \times 10^{10} \text{ cm}^{-2}$ Bottom (minority) layer: WS, top (majority) layer: FQHE regime.

Original purpose (Shayegan group): geometric resonances of CFs arxiv 1410.3435 (Deng,Liu,Jo,Pfeiffer,West, Baldwin,Shayegan)



- Charge transfer for $v\sigma l$; gone for lower v.
- n_L by subtraction of n_L (by FQHE) from SdH total density
- arxiv 1410.3435 (Deng,Liu,Jo, Pfeiffer,West, Baldwin,Shayegan)



Minority layer pinning mode spectra





 f_{pk} responds to FQHE in majority layer Interlayer coupling, small enough n_L : Lattice constant *a* exceeding separation d≈40nm

Sum rule: Harmonic oscillator model of pinning mode $V(x,y) = \frac{M\omega_0^2(x^2 + y^2)}{2}$ B V(r) "pinning" frequency ω_0 , cyclotron frequency $\omega_c = eB/m^*$ Two modes: $\omega_+ > \omega_c$ $\mathbf{\succ} \quad \omega_{-} = \omega_{0}^{2} / \omega_{c} \text{ (for } \omega_{0} \ll \omega_{c})$ $\mathbf{\bigsqcup} \quad \text{Microwave resonance}$ Charge in "pinning" potential Observed resonance frequency: $f_{pk} = \omega_0^2 / 2\pi \omega_c$ $\omega_{\rm sum}$ rule: $S_{-} = \int_0^\infty {\rm Re}[\sigma_{xx}(f)] df = {\sf n}_{\rm osc} e \pi f_{pk}/2B$

from measured S/f_{pk} , participating carrier density: $n_{osc} = 2BS_{pk}/e\pi f_{pk}$

Participation ratio

$$/=n_{osc}/n$$

Fukuyama and Lee; Millis, Normand, Littlewood

f_{pk} increases as n decreases: Weak pinning



Generic behavior

Reducing n \Rightarrow weaker carrier-carrier interaction \Rightarrow Carriers "fall further into impurity potential" \Rightarrow Average pinning, so f_{pk} increases

•In weak pinning: $f_{pk} \sim 1/C_t$ inversely as shear modulus.

n_{osc} characterizes effect of majority-layer state: image charge

Two ways to get participating density n_{osc} from resonance : i. $n_{osc} \propto f_{pk}^{-2}$: empirically established

ii. $n_{osc} = 2BS/e\pi f_{pk}$: sum rule for n, S is integrated Re $\sigma_{xx}(f)$



 n_{I} : "image charge" density, reduction in resonance-measured density from true density, n_{I}

local compressibility measurement

Two independent ways to get n_I

In pinning theory (Chitra et al 2001,Fertig 2000, Fogler 2001) f_{pk} comes from static quantity Larkin length + Lorenz force +shear modulus

Sum rule measures all oscillating charge

"image" charge in majority layer appears to oscillate along with WS charges.

Wide quantum well

Increasing density, *n*



Air-gapped glass top gate: necessary for microwaves

Wide quantum wells WQW



n

• two-component for $\gamma = E_c / \Delta = e^2 / 4\pi \epsilon_0 \epsilon l_B \Delta > 16$

γ: measure of *bilayerness*

- transition to solid
 - single layer : $v \sim 1/5$
 - parallel single layers v~2/5 (1/5 per layer)
- Interlayer correlated:
 - eg $\frac{1}{2}$ FQHE

Manoharan, Suen, Santos, Shayegan PRL '96



Resonance onset









Re (σ_{xx})



Hatke, Liu, Engel, Shayegan, Pfeiffer, West, Baldwin, Nature Comm. 6, 7071 (2015)

five phase transitions in terminating insulator



dashed lines: experimental limits

Phase Diagram (80 nm)



Possible explanations

- CFWC: Composite Fermion flux number (2p) transitions
 Archer, Park, Jain, PRL '13; Rhim, Jain, Park, PRB '15
 p → 2,3,4, as v goes below~ 1/5,1/7, 1/9
- Single layer no disorder
- Shear modulus has discontinuity at transitions



Possible explanations

 Bilayer structural HF theory : Narasihhan Ho, '95 , Cote, Fertig, '95





Wrong *trajectory*

Admixture/microemulsion



- Resonance turns on gradually as γ increases
- Transitions most pronounced at moderate γ
- Role of liquid or other nonresonant component
- Admixture/microemulsion, (Kivelson, Spivak)



Tilt sample in field:Microwave Spectra (w = 80 nm)



n=1.21

In-plane B increases sharpness, hence peak Re σ_{xx} .

Transition movement (80 nm)

•
$$n = 1.11;$$
 • $n = 1.21;$ • $n = 1.27;$ • $n = 1.33$



Increasing *n* or θ (bilayerness):

- Phase transition position moves to higher v
- Reduction in tunneling
- Not consistent with HF predictions



Two regimes:

- Low θ : modification of Δ_{SAS}
- High θ : *n* and θ independent transitions---v determined



- DQW: CF liquid +WS $V_H \Re n_I$
- Resonance associated with a bilayer electron solid in a wide quantum well
 - Deep in the insulating state: *five* phase transitions *Possibilities*...
 - CF vortex number transitions
 - Liquid/solid emulsion
 - Bilayer stacking transitions
 - *v* characterizes transitions at high in-plane field

Hatke, Liu, Engel, Shayegan, Pfeiffer, West, Baldwin, Nature Comm. **6**, 7071 (2015) Hatke, Liu, Engel, Shayegan, Pfeiffer, West, Baldwin, arXiv: 1504.08182